

## **SiC JFET Division**

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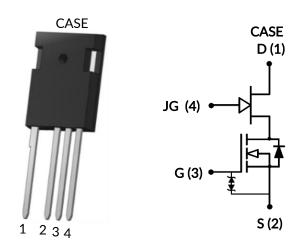








## UG3SC120009K4S



Part Number	Package	Marking
UG3SC120009K4S	TO-247-4L	UG3SC120009K4S







## Silicon Carbide (SiC) Combo JFET - EliteSiC, Power N-Channel, TO-247-4L, 1200 V, 7.6 mohm

Rev. C, January 2025

#### Description

Qorvo's UG3SC120009K4S "Combo-FET" integrates both a 1200V SiC JFET and a Low Voltage Si MOSFET into a single TO-247-4L package. This innovative approach allows users to create circuitry that would enable a normally-off switch while leveraging the benefits of a normally-on SiC JFET. These benefits include ultra-low onresistance ( $R_{\rm DS(on)}$ ) to minimize conduction losses and the exceptional robustness characteristic of a simplified JFET device structure, making it capable of handling the high-energy switching required in circuit protection applications. For switch-mode power conversion application, this device provides separate access to the JFET and MOSFET gates for improved speed control and ease of paralleling multiple devices.

#### **Features**

- ◆ Single digit R<sub>DS(on)</sub>
- Normally-off capability
- Improved speed control
- Improved parallel device operation (3+ FETs)
- Operating temperature: 175C (max)
- High pulse current capability
- Excellent device robustness
- Silver-sintered die attach for excellent thermal resistance
- Short circuit rated
- AECQ Qualified

#### Typical applications

- Solid State / Semiconductor Circuit Breaker
- Solid State / Semiconductor Relay
- Battery Disconnects
- Surge Protection
- Inrush Current Control
- High power switch mode converters (>25kW)















## **Maximum Ratings**

Parameter	Symbol	Test Conditions	Value	Units
Drain-source voltage	$V_{DS}$		1200	V
JFET Gate (JG) to source voltage	\/	DC	-30 to +3	V
JFET Gate (JG) to source voltage	$V_{JGS}$	AC <sup>1</sup>	-30 to +30	V
MOSFET Gate (G) to source voltage	V	DC	-20 to +20	V
MOSFET Gate (G) to source voltage	$V_{GS}$	AC (f > 1Hz)	-25 to +25	V
Continuous drain current <sup>2</sup>	I <sub>D</sub>	T <sub>C</sub> < 112°C	120	Α
Pulsed drain current <sup>3</sup>	I <sub>DM</sub>	T <sub>C</sub> = 25°C	550	Α
Single pulsed avalanche energy <sup>4</sup>	E <sub>AS</sub>	L=15mH, I <sub>AS</sub> =8.6A	555	mJ
Power dissipation	P <sub>tot</sub>	T <sub>C</sub> = 25°C	789	W
Maximum junction temperature	$T_{J,max}$		175	°C
Operating and storage temperature	$T_J$ , $T_{STG}$		-55 to 175	°C
Max. lead temperature for soldering, 1/8" from case for 5 seconds	T <sub>L</sub>		250	°C

- 1. +30V AC rating applies for turn-on pulses <200ns applied with external  $R_{\text{G}}$  >  $1\Omega.$
- 2. Limited by bondwires
- 3. Pulse width  $t_p$  limited by  $T_{J,max}$
- 4. Starting  $T_J = 25$ °C

#### **Thermal Characteristics**

Parameter	Symbol	Test Conditions	Value			Units
Parameter			Min	Тур	Max	Offics
Thermal resistance, junction-to-case	$R_{\theta JC}$			0.15	0.19	°C/W

















## Electrical Characteristics ( $T_J$ = +25°C and $V_{JGS}$ = 0V unless otherwise specified)

### **Typical Performance - Static**

Parameter	Symbol Test Co		onditions		Value		Units
Parameter	Зуппоп	rest Conditions		Min	Тур	Max	Offics
Drain-source breakdown voltage	$BV_{DS}$	I <sub>D</sub> =1mA	, V <sub>GS</sub> =0V	1200			V
Total drain leakage current			/, T <sub>J</sub> = 25°C, <sub>5</sub> =0V		6	600	
	I <sub>DSS</sub>	$V_{GS}=0V$ $V_{DS}=1200V, T_{J}=175^{\circ}C,$ $V_{GS}=0V$			65		μΑ
Total JFET gate leakage current	$I_{JGSS}$	V <sub>JGS</sub> =-20V, V <sub>GS</sub> =12V			15	300	μΑ
Total MOSFET gate leakage current	$I_{GSS}$	V <sub>GS</sub> =-20	V / +20V		5	20	μΑ
	R <sub>DS(on)</sub>	V <sub>GS</sub> =12V, I <sub>D</sub> =100A	$V_{JGS}=2V$ , $T_{J}=25$ °C		7.6		mΩ
Drain-source on-resistance			T <sub>J</sub> =25°C		8.8	11	
			T <sub>J</sub> =125°C		13.7		
			T <sub>J</sub> =175°C		18.5		
JFET gate threshold voltage	$V_{\text{JG(th)}}$	$V_{DS}$ =5V, $V_{GS}$ =12V, $I_{D}$ =320mA		-9.3	-7	-4.7	V
MOSFET gate threshold voltage	$V_{G(th)}$	$V_{DS}=5V$ , $V_{JGS}=0V$ , $I_{D}=10$ mA		4	4.7	6	V
JFET gate resistance	$R_{JG}$	f=1MHz, open drain			0.54		Ω
MOSFET gate resistance	$R_{G}$	f=1MHz,	open drain		3.5	6	Ω

## Typical Performance - Reverse Diode

Parameter	Symbol	Test Conditions	Value			Units
Parameter	Зуппрог	rest Conditions	Min	Тур	Max	Units
Diode continuous forward current <sup>1</sup>	I <sub>S</sub>	T <sub>C</sub> < 112°C			120	А
Diode pulse current <sup>2</sup>	$I_{S,pulse}$	T <sub>C</sub> = 25°C			550	Α
		V <sub>GS</sub> =0V, I <sub>S</sub> =100A,		1.65	2	V
Forward voltage	$V_{FSD}$	T <sub>J</sub> =25°C		1.05		
1 of ward voltage	▼ FSD	$V_{GS}$ =0V, $I_S$ =100A,		2.4		
		T <sub>J</sub> =175°C				
Doverso recovery charge		$V_{DS}$ =800V, $I_{S}$ =100A,		785		~C
Reverse recovery charge	$Q_{rr}$	$V_{GS}=V_{JGS}=0V$ , $R_{JG}=0.7\Omega$		/65		nC
Dovorco rocovorutimo	1	di/dt=1200A/μs,		110		
Reverse recovery time	t <sub>rr</sub>	T <sub>J</sub> =25°C		119		ns
		V <sub>DS</sub> =800V, I <sub>S</sub> =100A,				
Reverse recovery charge	$Q_{rr}$	$V_{GS}=V_{JGS}=0V, R_{JG}=0.7\Omega$		815		nC
		di/dt=1200A/μs,				
Reverse recovery time	t <sub>rr</sub>	<sub>Т,</sub> =150°С		124		ns















## Typical Performance - Dynamic with MOSFET gate as control terminal and $V_{\text{JGS}}$ =0V

Damanadan	Cymah al Taat Cam dit	T+ C	Value			Linita
Parameter	Symbol	Test Conditions –	Min	Тур	Max	- Units
MOSFET input capacitance	C <sub>iss</sub>	V <sub>DS</sub> =800V, V <sub>GS</sub> =0V,		8157		
Output capacitance	$C_{oss}$	f=100kHz		351		pF
Reverse transfer capacitance	$C_{rss}$	T-100KHZ		2		
Effective output capacitance, energy related	$C_{oss(er)}$	V <sub>DS</sub> =0V to 800V,		394		pF
Effective output capacitance, time related	$C_{oss(tr)}$	V <sub>GS</sub> =0V		920		pF
C <sub>OSS</sub> stored energy	$E_{oss}$	V <sub>DS</sub> =800V, V <sub>GS</sub> =0V		125		μJ
Total gate charge	$Q_{G}$	V 000V 1 400A		196		
Gate-drain charge	$Q_{GD}$	$V_{DS}$ =800V, $I_{D}$ =100A, $V_{GS}$ = 0V to 15V		41		nC
Gate-source charge	$Q_{GS}$	V <sub>GS</sub> - 0V to 13V		41		
Turn-on delay time	t <sub>d(on)</sub>	Notes 5 and 6		160		ns
Rise time	t <sub>r</sub>	$V_{DS}$ =800V, $I_{D}$ =100A, $V_{GS}$ =0V to +15V, $R_{G ON}$ =1 $\Omega$ , $R_{G OFF}$ =2 $\Omega$ ,		73		
Turn-off delay time	$t_{d(off)}$			210		
Fall time	t <sub>f</sub>	$R_{JG\_ON}$ =0.7 $\Omega$ , $R_{JG\_OFF}$ =3.3 $\Omega$ ,		59		
Turn-on energy	E <sub>ON</sub>	Inductive Load, FWD: same device with $V_{GS} =$		11.5		
Turn-off energy	$E_{OFF}$	$OV, V_{JGS} = OV, R_G = 2\Omega,$		2.5		mJ
Total switching energy	$E_TOTAL$	$R_{JG}=0.7\Omega$ , $T_{J}=25$ °C		14		
Turn-on delay time	$t_{\text{d(on)}}$	Notes 5 and 6		158		
Rise time	$t_r$	V <sub>DS</sub> =800V, I <sub>D</sub> =100A,		79		- ns
Turn-off delay time	$t_{\text{d(off)}}$	$V_{GS}=0V \ to +15V,$ $R_{G\_ON}=1\Omega, \ R_{G\_OFF}=2\Omega,$ $R_{JG\_ON}=0.7\Omega, \ R_{JG\_OFF}=3.3\Omega,$ Inductive Load, $FWD: \ same \ device \ with \ V_{GS}=0V, \ R_{JG}=0.7\Omega, \ T_{J}=150^{\circ}C$		53		113
Fall time	$t_f$			212		
Turn-on energy	E <sub>ON</sub>			12.3		
Turn-off energy	$E_{OFF}$			2.8		mJ
Total switching energy	$E_TOTAL$			15.1		

- 5. Measured with the half-bridge mode switching test circuit in Figure 23.
- 6. Driven with the ClampDRIVE method as descriped in the section "Recommended Gate Drive Approach: ClampDRIVE method".















## Typical Performance - Dynamic with JFET gate as control terminal and $V_{\text{GS}}$ =+12V

Parameter	Symbol	Test Conditions	Value			Units
Parameter	Syllibol		Min	Тур	Max	Offics
JFET input capacitance	$C_{Jiss}$	- V <sub>DS</sub> =800V, V <sub>JGS</sub> =-20V, f=100kHz		8110		
JFET output capacitance	C <sub>Joss</sub>			368		pF
JFET reverse transfer capacitance	C <sub>Jrss</sub>			358		
JFET total gate charge	$Q_{JG}$	V <sub>DS</sub> =800V, I <sub>D</sub> =100A, V <sub>JGS</sub> = -18V to 0V		830		
JFET gate-drain charge	$Q_{JGD}$			520		nC
JFET gate-source charge	$Q_{JGS}$			120		

#### Typical Performance Diagrams - MOSFET gate as control terminal and $V_{JGS}$ =0V

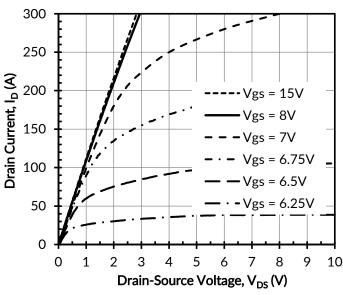


Figure 1. Typical output characteristics at  $T_J$  = - 55°C,  $t_p$  < 250 $\mu s$ 

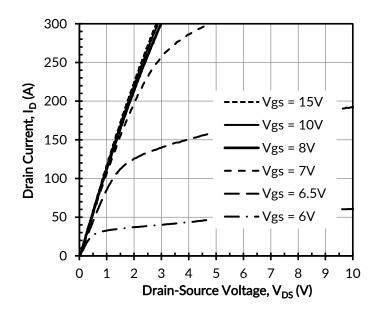


Figure 2. Typical output characteristics at  $T_J$  = 25°C,  $t_p$  < 250 $\mu$ s







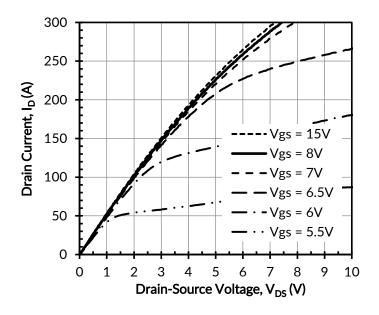








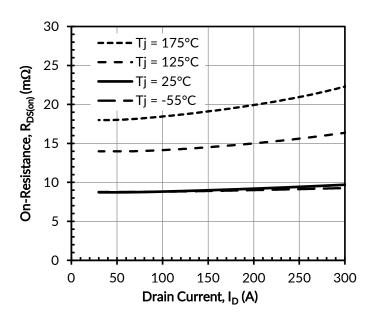




2.5 On Resistance, R<sub>DS\_ON</sub> (P.U.) 2.0 1.5 1.0 0.5 0.0 25 50 75 100 125 150 175 -75 -50 -25 0 Junction Temperature, T<sub>J</sub> (°C)

Figure 3. Typical output characteristics at  $T_J = 175$ °C,  $t_{\rm p} < 250 \mu s$ 

Figure 4. Normalized on-resistance vs. temperature at  $V_{GS}$  = 12V and  $I_D$  = 100A



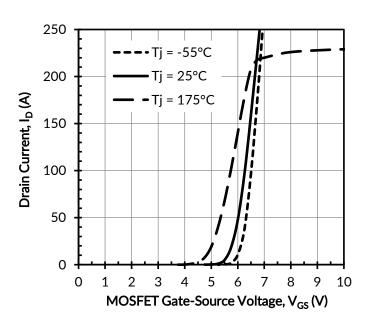


Figure 5. Typical drain-source on-resistances at  $V_{GS}$  = 12V

Figure 6. Typical transfer characteristics at  $V_{DS} = 5V$ 

















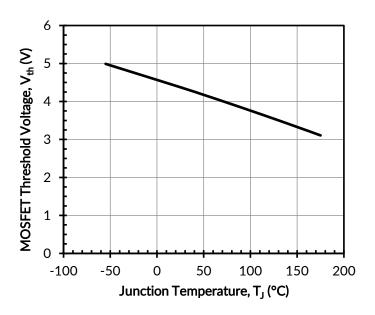


Figure 7. MOSFET threshold voltage vs. junction temperature at  $V_{DS}$  = 5V and  $I_D$  = 10mA

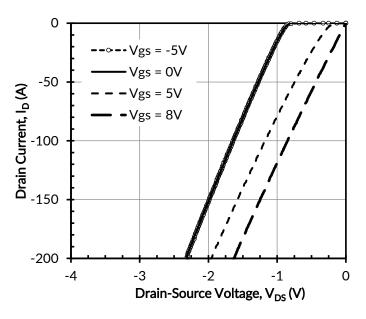


Figure 9. 3rd quadrant characteristics at  $T_J = -55$ °C

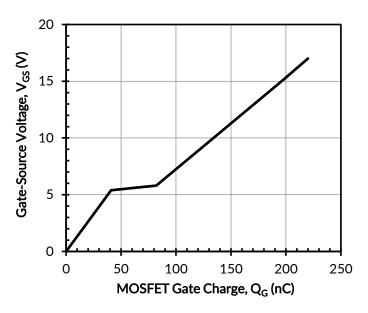


Figure 8. Typical MOSFET gate charge at  $V_{DS}$  = 800V and  $I_D = 100A$ 

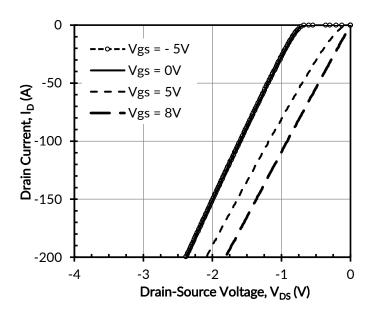


Figure 10. 3rd quadrant characteristics at  $T_J = 25$ °C







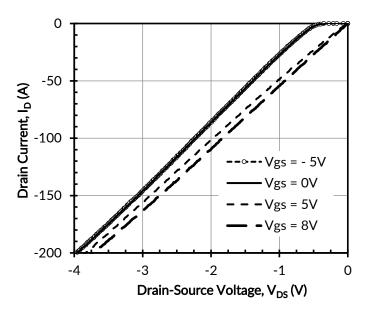








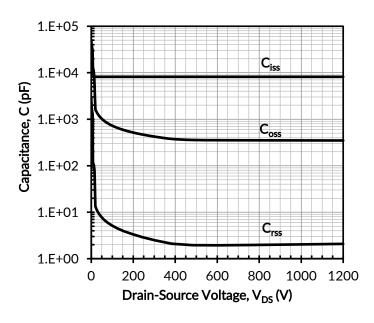
8



300 250 200 150 100 50 0 200 400 600 800 1000 1200 Drain-Source Voltage, V<sub>DS</sub> (V)

Figure 11. 3rd quadrant characteristics at  $T_J = 175$ °C

Figure 12. Typical stored energy in  $C_{OSS}$  at  $V_{GS} = 0V$ 



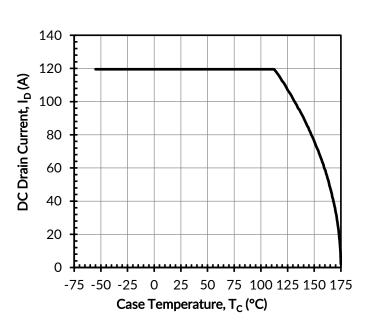


Figure 13. Typical capacitances at f = 100kHz and  $V_{\text{GS}}$  = 0V

Figure 14. DC drain current derating















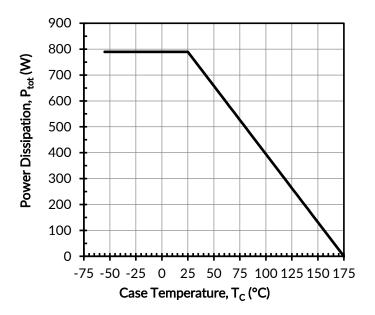


Figure 15. Total power dissipation

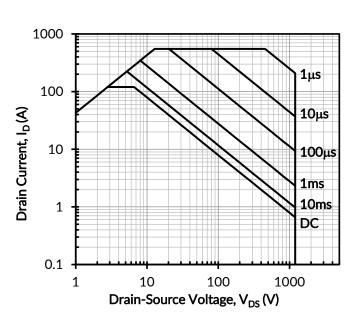


Figure 17. Safe operation area at  $T_C$  = 25°C, D = 0, Parameter  $t_p$ 

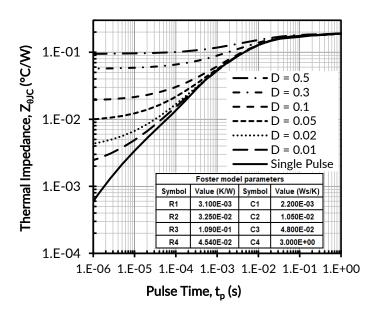


Figure 16. Maximum transient thermal impedance

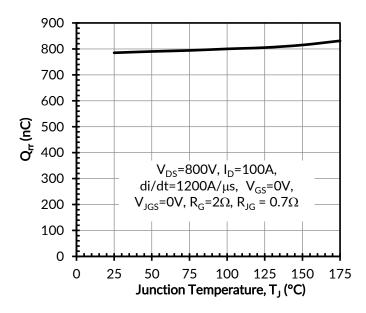


Figure 18. Reverse recovery charge  $Q_{rr}$  vs. junction temperature





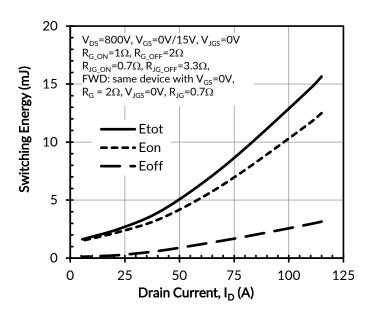








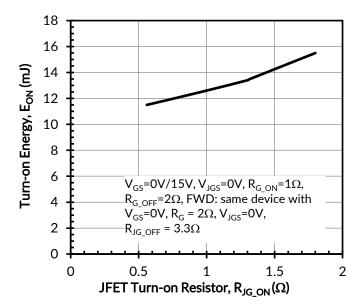




 $V_{GS} = 0V/15V, V_{JGS} = 0V, R_{G_{\_}ON} = 1\Omega,$ 8  $R_{G OFF} = 2\Omega$ , FWD: same device with  $V_{GS} = 0V, R_G = 2\Omega, V_{JGS} = 0V, R_{JG} = 0.7\Omega$ Furn-Off Energy, E<sub>OFF</sub> (mJ) 6 5 4 3 2 1 0 0 2 6 10 JFET Turn-off Resistor,  $R_{JG OFF}(\Omega)$ 

Figure 19. Clamped inductive switching energy vs. drain current at  $T_J = 25$ °C

Figure 20. Clamped inductive switching turn-off energy vs. JFET gate resistor  $R_{JG\_OFF}$  at  $V_{DS}$  = 800V,  $I_{D}$  = 100A, and  $T_{J}$  = 25°C



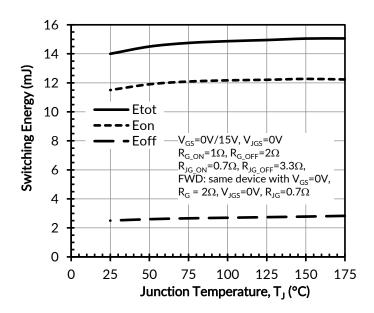


Figure 21. Clamped inductive switching turn-on energy vs. JFET gate resistor  $R_{JG\_ON}$  at  $V_{DS}$  = 800V,  $I_{D}$  = 100A, and  $T_{J}$  = 25°C

Figure 22. Clamped inductive switching energy vs. junction temperature at  $V_{DS}$  = 800V and  $I_D$  = 100A

















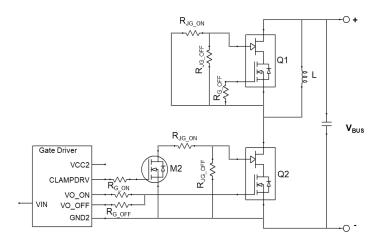


Figure 23. Schematic of the half-bridge mode switching test circuit with ClampDRIVE method.

#### Typical Performance Diagrams - JFET gate as control terminal and $V_{GS}$ =+12V

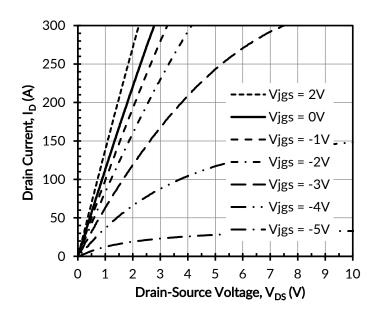


Figure 24. Typical output characteristics with JFET gate as control at  $T_J$  = - 55 °C,  $t_p$  <  $250\mu s$ 

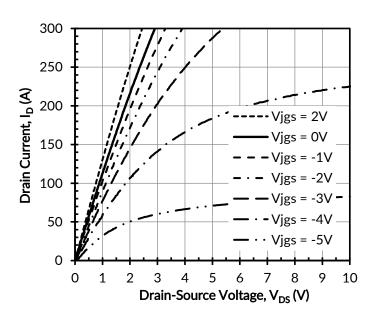


Figure 25. Typical output characteristics with JFET gate as control at  $T_J$  = 25°C,  $t_p$  < 250 $\mu$ s





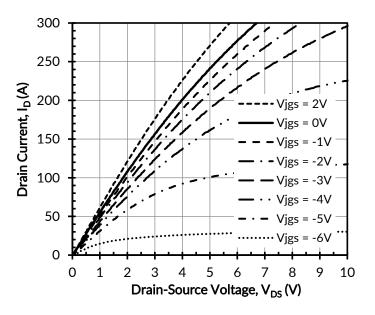












3 Gate-Source Voltage, V<sub>JGS</sub> (V) 0 -3 -6 -9 -12 -15 -18 200 0 400 600 800 1000 JFET Gate Charge, Q<sub>JG</sub> (nC)

Figure 26. Typical output characteristics with JFET gate as control at  $T_J$  = 175°C,  $t_p$  < 250 $\mu s$ 

Figure 27. Typical JFET gate charge at  $V_{DS}$  = 800V and  $I_{D}$  = 100A

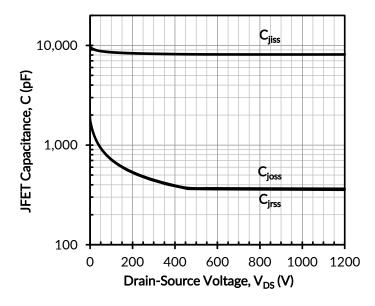


Figure 28. Typical JFET capacitances at f = 100kHz and  $V_{JGS}$  = -20V















#### Recommended Gate Drive Approach: ClampDRIVE method

Since both JFET gate and MOSFET gate are accessible, more parameters and approaches can be used to control the switching behaviors of the device and make the device suitable for a wide range applications from solid state circuit breakers requiring ultra-high current turn-off capability to motor drives requiring fast switching speed. The recommended gate drive approach is the ClampDRIVE method, with which the desired turn-on speed, turn-off speed and reverse recovery performance can be achieved at the same time. The main idea of this method is to dynamically tune the JFET gate resistor value  $R_{JG}$  such that, in the off-state,  $R_{JG}$  is small enough not to cause a reverse recovery issue, and during turn-off transient,  $R_{JG}$  is set to a higher value for the desired turn-off performance. This method can be easily implemented using a commercial off-the-shelf gate driver with miller clamp pre-driver output, as illustrated in Figure A. VIN is the gate driver input signal. VO is the gate driver output and CLAMPDRV is the gate driver miller clamp pre-driver output. M2 is the clamp MOSFET used to control the JFET gate resistance. The MOSFET M2 is directly controlled by the CLAMPDRV signal.

In the on-state, CLAMPDRV is low which turns the MOSFET M2 off, thus, the effective JFET gate resistance is  $R_{JG\_OFF}$ . During the turn-off transient, CLAMPDRV is kept low until the device is fully off. This means the JFET gate resistance is  $R_{JG\_OFF}$  during the turn-off process, and  $R_{GJ\_OFF}$  can be used to effectively control turn-off speed. After the device is fully off, CLAMPDRV is changed to high level, which turns the MOSFET M2 on.

In the off-state, CLAMPDRV is high and the clamp MOSFET M2 is in on-state. The effective JFET gate resistance is equal to the parallel combination of  $R_{JG\_OFF}$  and  $R_{JG\_ON}$ .  $R_{JG\_ON}$  can be selected small enough to prevent the reverse recovery issue. During the turn-on transient, the JFET gate current may flow from the cascode source through the body diode of the MOSFET M2 and  $R_{JG\_ON}$  into the JFET gate, so, the turn-on process is also determined by  $R_{JG\_ON}$ .

In summary, the optimum switching performance of the SiC cascode FETs can be realized with the ClampDRIVE method by selecting proper JFET gate resistors  $R_{JG\_ON}$  and  $R_{JG\_OFF}$ 

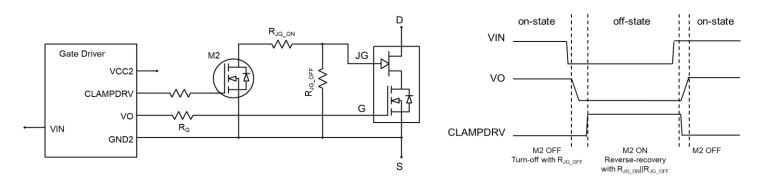


Figure A. Circuit schematic and timing diagram of the ClampDRIVE method















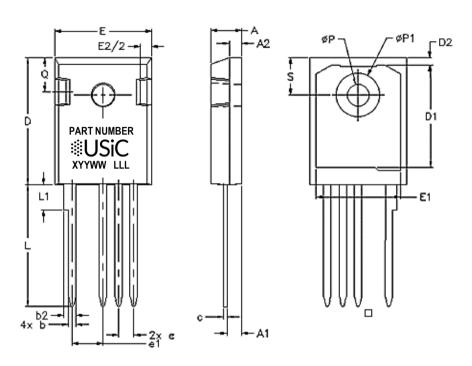
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# TO-247-4L PACKAGE OUTLINE, PART MARKING AND TUBE SPECIFICATIONS

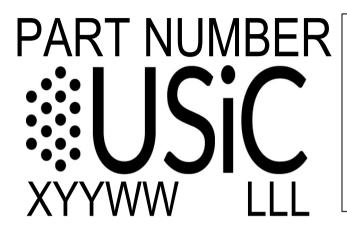
## **PACKAGE OUTLINE**



DIM	INCHES		MILLIMETERS		
	MIN	MAX	MIN	MAX	
Α	0.185	0.209	4.7	5.31	
A1	0.087	0.102	2.21	2.59	
A2	0.059	0.098	1.5	2.49	
b	0.039	0.055	0.99	1.4	
b2	0.065	0.094	1.65	2.39	
С	0.015	0.035	0.38	0.89	
D	0.819	0.845	20.8	21.46	
D1	0.515	-	13.08	-	
D2	0.02	0.053	0.51	1.35	
E	0.61	0.64	15.49	16.26	
е	0.100 BSC		2.54 BSC		
e1	0.19	0.21	4.83	5.33	
E1	0.53	-	13.46	-	
E2	0.14	0.16	3.56	4.06	
L	0.78	0.8	19.81	20.32	
L1	-	0.177		4.5	
ФР	0.14	0.144	3.56	3.66	
ФР1	0.278	0.291	7.06	7.39	
Q	0.212	0.244	5.38	6.2	
S	0.243 BSC		6.17 BSC		



## TO-247-4L PACKAGE OUTLINE, PART MARKING AND TUBE SPECIFICATIONS



PART NUMBER = REFER TO
DS PN DECODER FOR DETAILS

X = ASSEMBLY SITE

YY = YEAR

WW = WORK WFFK

LLL = LOT ID

#### **PACKING TYPE**

**ANTI-STATIC TUBE** 

**QUANTITY /TUBE: 30 UNITS** 

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